Description

The series of devices uses **Super Trench II** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g. This device is ideal for high-frequency switching and synchronous rectification.

Application

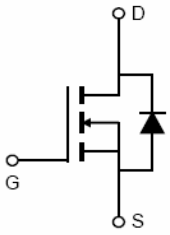
- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

General Features

- V_{DS} =100V,I_D =135A
  $R_{DS(ON)}$=3.65mΩ , typical (TO-220)@ V_{GS}=10V
  $R_{DS(ON)}$=3.5mΩ , typical (TO-263)@ V_{GS}=10V
- Excellent gate charge x $R_{DS(on)}$ product(FOM)
- Very low on-resistance $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating
- Pb-free Mold Compound

TO-220C

TO-263



Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST10N036-TC	VST10N036	TO-220C	-	-	-
VST10N036-T3	VST10N036	TO-263	-	-	-

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous	I_D	135	A
Drain Current-Continuous(T_C=100℃)	I_D (100℃)	108	A
Pulsed Drain Current	I_{DM}	540	A
Maximum Power Dissipation	P_D	220	W
Derating factor		1.47	W/℃
Avalanche Current(Note 1)	I_{AR}	55	A
Single pulse avalanche energy (Note 5)	E_{AS}	1156	mJ
Operating Junction and Storage Temperature Range	T_J,T_{STG}	-55 To 175	℃

Thermal Characteristic

Thermal Resistance,Junction-to-Case(Note 2)	$R_{\theta JC}$	0.68	℃/W
Thermal Resistance,Junction-to-Ambient (Note 2)	$R_{\theta JA}$	50	℃/W

Electrical Characteristics (T_C=25℃unless otherwise noted)

Parameter	Symbol	Condition		Min	Typ	Max	Unit
Off Characteristics							
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V I_D=250μA		100		-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=100V,V_{GS}=0V		-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	V_{GS}=±20V,V_{DS}=0V		-	-	±100	nA
On Characteristics (Note 3)							
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS},I_D=250μA		2.0	3.0	4.0	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=65A	TO-220	-	3.65	3.9	mΩ
			TO-263		3.5	3.9	mΩ
Gate resistance	R_G			-	1.5	-	Ω
Forward Transconductance	g_{FS}	V_{DS}=5V,I_D=65A			90	-	S
Dynamic Characteristics (Note4)							
Input Capacitance	C_{lss}	V_{DS}=50V,V_{GS}=0V, F=1.0MHz		-	7450	9685	PF
Output Capacitance	C_{oss}			-	618	803	PF
Reverse Transfer Capacitance	C_{rss}			-	37	60	PF
Switching Characteristics (Note 4)							
Turn-on Delay Time	$t_{d(on)}$	V_{DD}=50V,I_D=65A V_{GS}=10V,R_G=1.6Ω		-	20	-	nS
Turn-on Rise Time	t_r			-	11.5	-	nS
Turn-Off Delay Time	$t_{d(off)}$			-	48	-	nS
Turn-Off Fall Time	t_f			-	10	-	nS
Total Gate Charge	Q_g	V_{DS}=50V,I_D=65A, V_{GS}=10V		-	116	150	nC
Gate-Source Charge	Q_{gs}			-	39	50	nC
Gate-Drain Charge	Q_{gd}			-	32	42	nC
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V_{SD}	V_{GS}=0V,I_S=65A		-		1.2	V
Diode Forward Current (Note 2)	I_S			-	-	135	A
Reverse Recovery Time	t_{rr}	T_J = 25°C, I_F = I_S di/dt = 100A/μs (Note3)		-	76	-	nS
Reverse Recovery Charge	Qrr			-	150	-	nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production
5. EAS condition : Tj=25℃,V_{DD}=50V,V_G=10V,L=0.5mH,Rg=25Ω

Typical Electrical and Thermal Characteristics

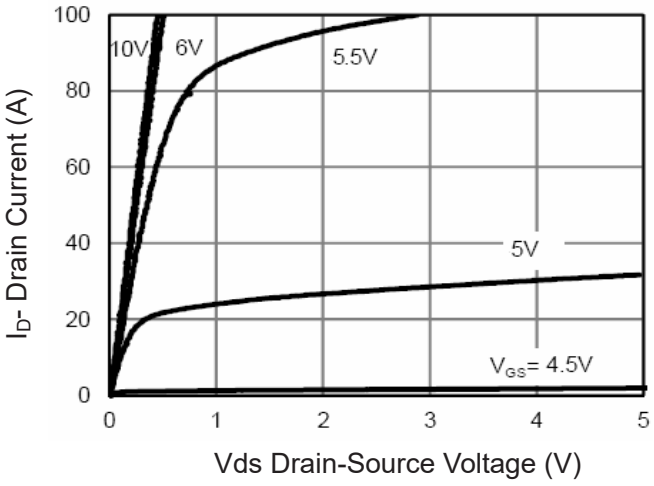


Figure 1 Output Characteristics

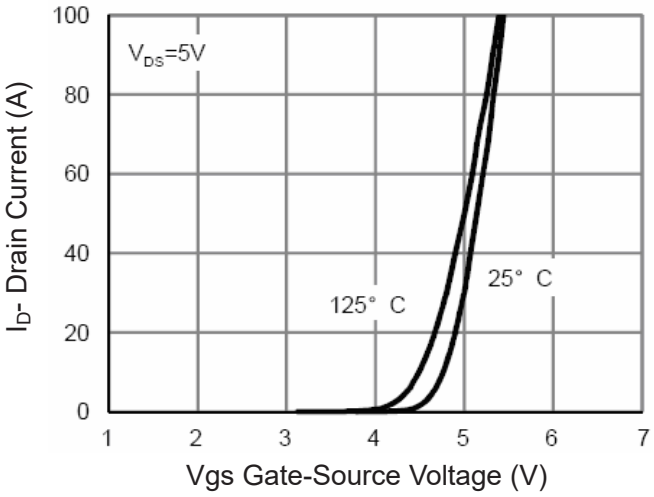


Figure 2 Transfer Characteristics

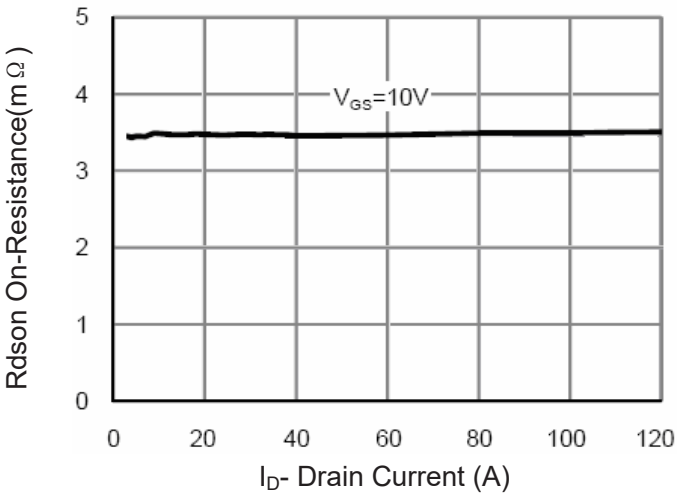


Figure 3 Rdson- Drain Current

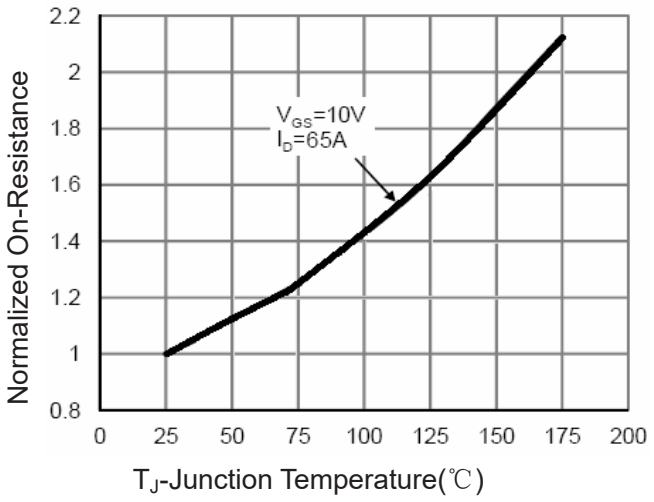


Figure 4 Rdson-Junction Temperature

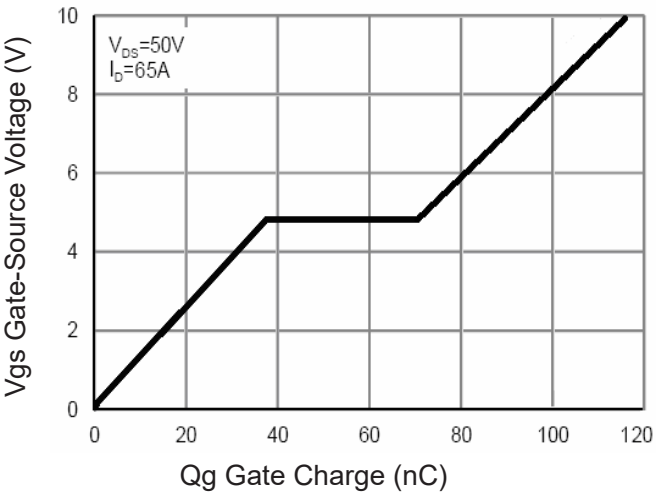


Figure 5 Gate Charge

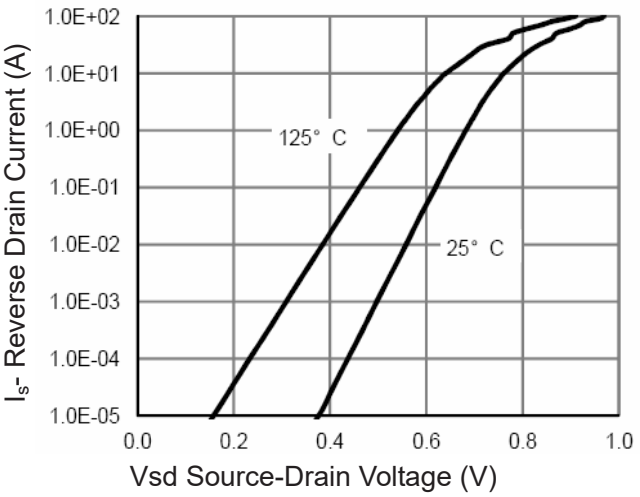


Figure 6 Source- Drain Diode Forward

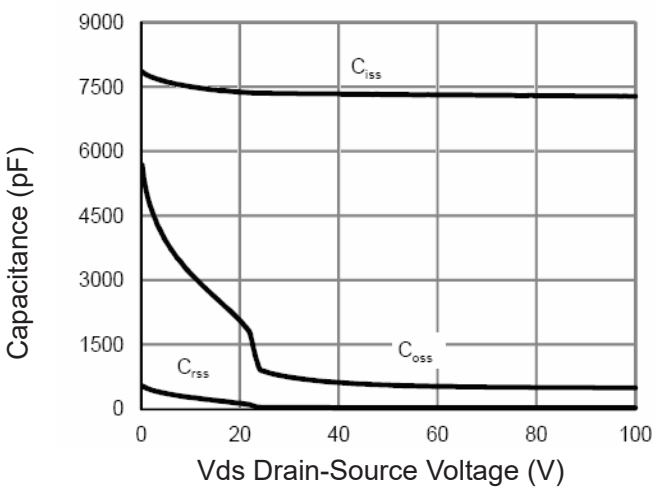


Figure 7 Capacitance vs Vds

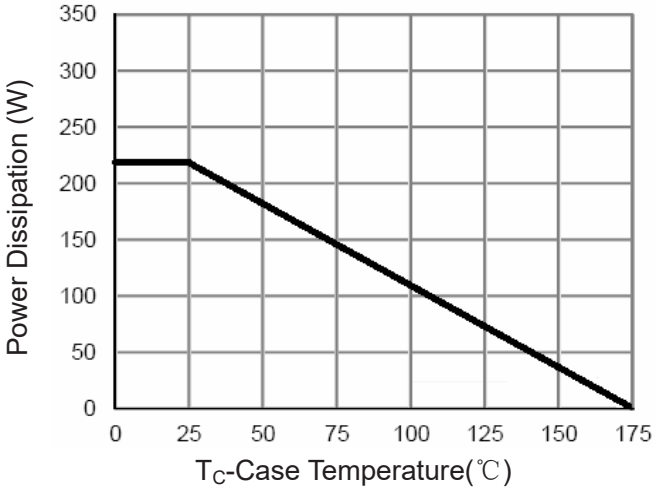


Figure 9 Power De-rating

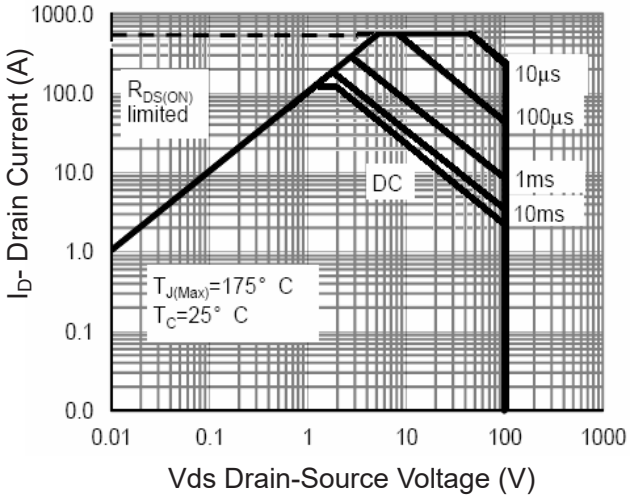


Figure 8 Safe Operation Area

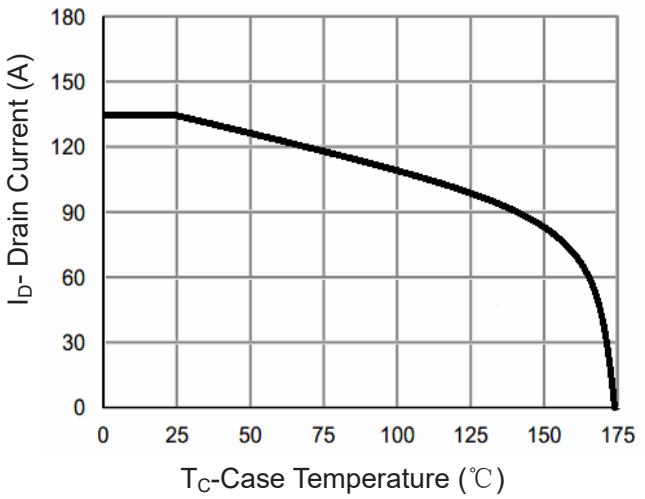


Figure 10 Current De-rating

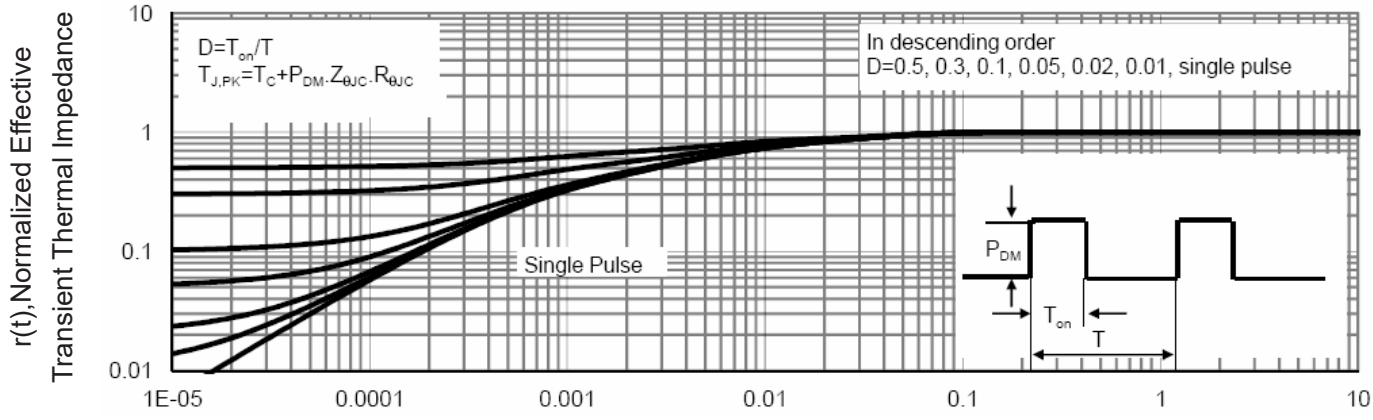


Figure 11 Normalized Maximum Transient Thermal Impedance